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Kind regards,

Team Nexperia



Product data sheet

## 1. General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

## 2. Features and benefits

- AEC Q101 compliant
- Low conduction losses due to low on-state resistance

## 3. Applications

• Automotive and general purpose power switching

## 4. Quick reference data

Table 1. Q	uick reference data						
Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	-	100	V
I <sub>D</sub>	drain current	T <sub>mb</sub> = 25 °C		-	-	75	А
P <sub>tot</sub>	total power dissipation			-	-	300	W
Static chara	cteristics	1					
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 25 °C		-	12	15	mΩ
Avalanche r	uggedness	·	· · ·				
E <sub>DS(AL)S</sub>	non-repetitive drain- source avalanche energy	$I_D$ = 35 A; V <sub>sup</sub> ≤ 25 V; R <sub>GS</sub> = 50 Ω; V <sub>GS</sub> = 10 V; T <sub>j(init)</sub> = 25 °C; unclamped		-	-	120	mJ





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# 5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D
2	D	drain		
3	S	source		G C C C C C C C C C C C C C C C C C C C
mb	D	mounting base; connected to drain		mbb076 S
			TO-220AB (SOT78A)	

# 6. Ordering information

Table 3. Ordering information						
Type number	Package					
	Name	Description	Version			
BUK7515-100A	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78A			

BUK7515-100A

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## 7. Limiting values

#### Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

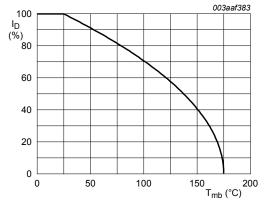
Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	100	V
V <sub>DGR</sub>	drain-gate voltage	R <sub>GS</sub> = 20 kΩ	-	100	V
V <sub>GS</sub>	gate-source voltage		-20	20	V
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C	-	300	W
I <sub>D</sub>	drain current		-	75	А
		T <sub>mb</sub> = 100 °C	-	60.8	А
I <sub>DM</sub>	peak drain current	T <sub>mb</sub> = 25 °C; pulsed	-	240	А
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Source-drain	diode				
l <sub>S</sub>	source current	T <sub>mb</sub> = 25 °C	-	75	А
I <sub>SM</sub>	peak source current	pulsed; T <sub>mb</sub> = 25 °C	-	240	А
Avalanche ru	uggedness	1		1	
E <sub>DS(AL)S</sub>	non-repetitive drain-source	$I_D$ = 35 A; $V_{sup} \le 25$ V; $R_{GS}$ = 50 Ω;	-	120	mJ

V<sub>GS</sub> = 10 V; T<sub>j(init)</sub> = 25 °C; unclamped

avalanche energy



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$



 $V_{GS} \ge 10 V$ 



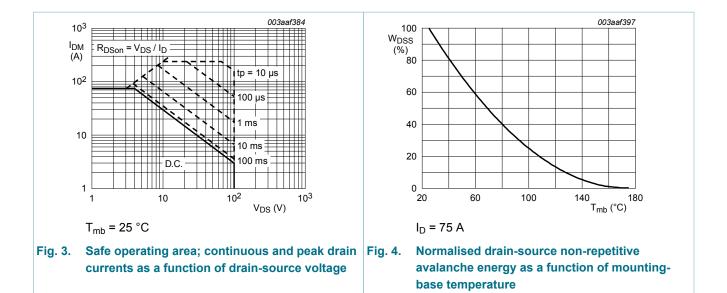
$$I_{der} = \frac{I_D}{I_{D(25^\circ C)}} \times 100\%$$

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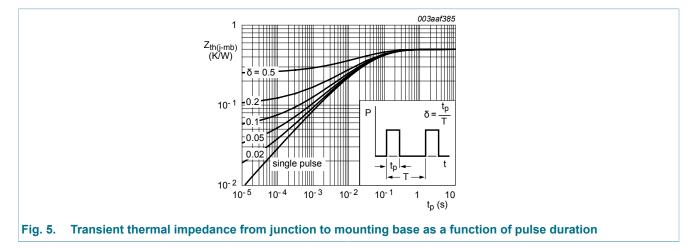
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## 8. Thermal characteristics

Table 5. The	ermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base		-	-	0.5	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	in free air	-	60	-	K/W



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## 9. Characteristics

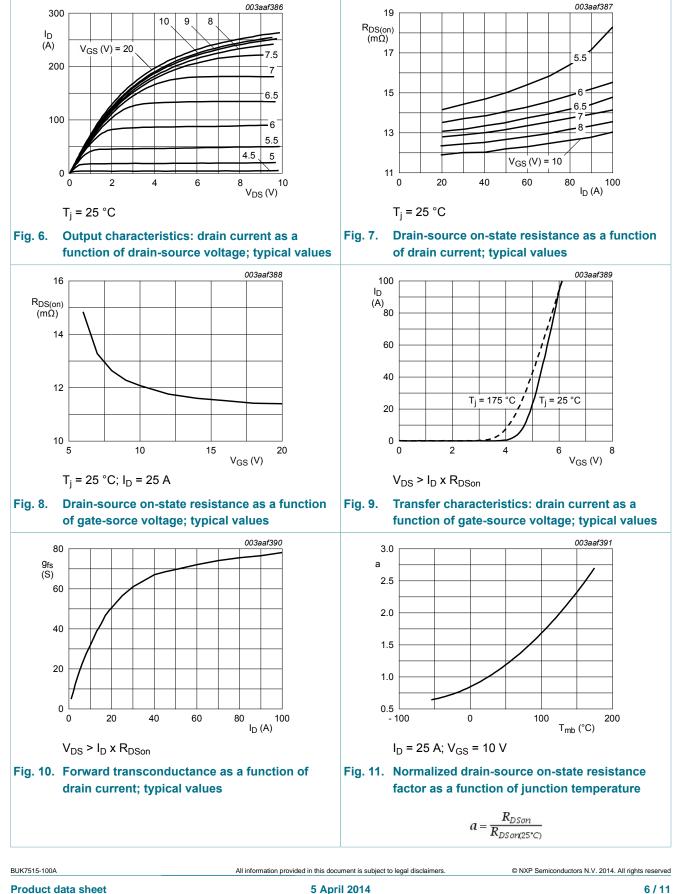
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	octeristics					
V <sub>(BR)DSS</sub>	BR)DSS drain-source	$I_D$ = 0.25 mA; $V_{GS}$ = 0 V; $T_j$ = 25 °C	100	-	-	V
	breakdown voltage	$I_D$ = 0.25 mA; $V_{GS}$ = 0 V; $T_j$ = -55 °C	89	-	-	V
V <sub>GS(th)</sub>	gate-source threshold	$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = 25 °C	2	3	4	V
	voltage	$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = 175 °C	1	-	-	V
		$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = -55 °C	-	-	4.4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS}$ = 100 V; $V_{GS}$ = 0 V; $T_j$ = 175 °C	-	-	500	μA
		$V_{DS}$ = 100 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C	-	0.05	10	μA
I <sub>GSS</sub>	gate leakage current	$V_{GS}$ = 20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	2	100	nA
		V <sub>GS</sub> = -20 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	2	100	nA
R <sub>DSon</sub>	drain-source on-state	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 175 °C	-	-	40.5	mΩ
resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; T <sub>j</sub> = 25 °C	-	12	15	mΩ	
Dynamic ch	aracteristics	1				
C <sub>iss</sub>	input capacitance	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz;	-	4500	6000	pF
C <sub>oss</sub>	output capacitance	$T_j = 25 \ ^{\circ}C$	-	550	660	pF
C <sub>rss</sub>	reverse transfer capacitance		-	305	400	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 30 V; R <sub>L</sub> = 1.2 $\Omega$ ; V <sub>GS</sub> = 10 V;	-	35	55	ns
t <sub>r</sub>	rise time	R <sub>G(ext)</sub> = 10 Ω; T <sub>j</sub> = 25 °C	-	85	125	ns
t <sub>d(off)</sub>	turn-off delay time		-	150	225	ns
t <sub>f</sub>	fall time		-	70	100	ns
L <sub>D</sub>	internal drain inductance	from contact screw on tab to centre of die; $T_j = 25 \ ^{\circ}C$	-	3.5	-	nH
		from drain lead 6 mm from package to centre of die; $T_j = 25 \text{ °C}$	-	4.5	-	nH
L <sub>S</sub>	internal source inductance	from source lead 6 mm from package to source bond pad ; $T_j = 25 \text{ °C}$	-	7.5	-	nH
Source-drai	n diode				1	
V <sub>SD</sub>	source-drain voltage	I <sub>S</sub> = 25 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	0.85	1.2	V
		I <sub>S</sub> = 75 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	1.1	-	V
t <sub>rr</sub>	reverse recovery time	I <sub>S</sub> = 75 A; dI <sub>S</sub> /dt = -100 A/μs;	-	80	-	ns
Q <sub>r</sub>	recovered charge	$V_{GS}$ = -10 V; $V_{DS}$ = 30 V; $T_j$ = 25 °C	-	0.35	-	μC

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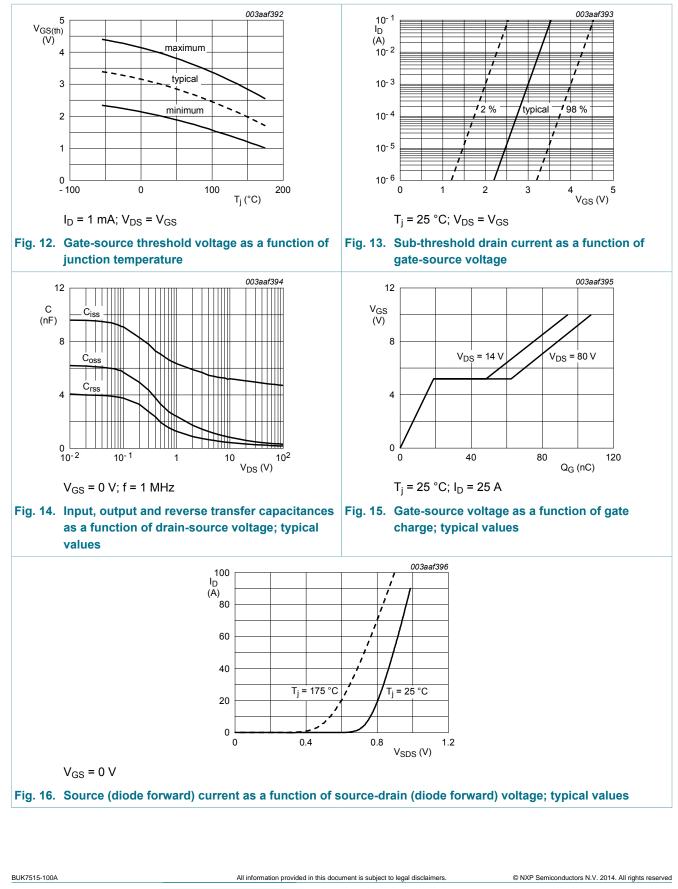


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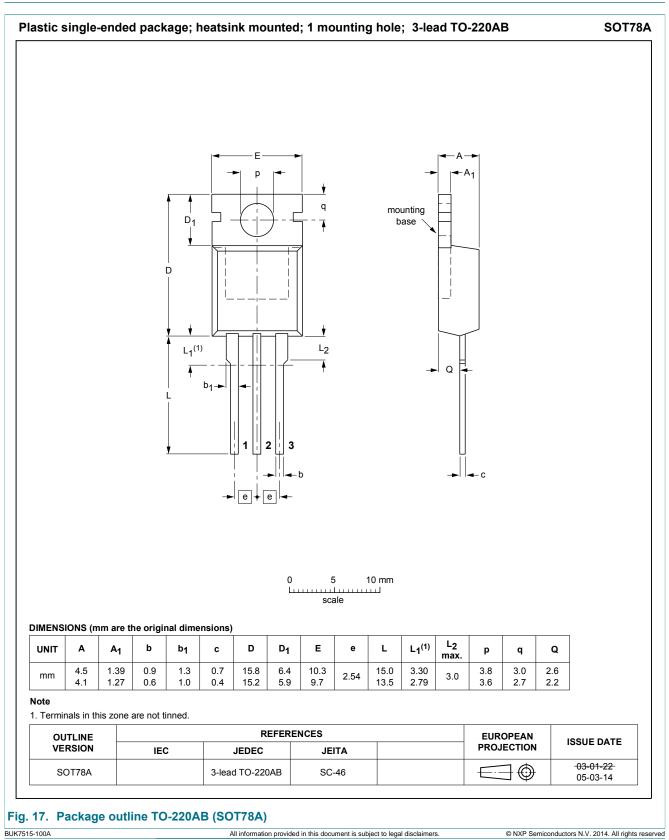
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## 10. Package outline



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## 11. Legal information

#### 11.1 Data sheet status

Document	Product	Definition
status [1][2]	status [3]	
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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